Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,553	ARAI, MASATOSHI	
Examiner	Art Unit	
Yonel Beaulieu	3661	

	SEARCHED			
Class	Subclass	Date	Examiner	
701	1	9/15/2006	YB	
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361	681			
	683			
359	837-844			
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